

Chip Ferrite Bead High Current Type

SIM86-32 series

MERITEK

FEATURE

- Operating temperature: -55°C ~ +125°C (Including self-temperature rise)
- Storage temperature: -55°C ~ +125°C (on board)
- Monolithic inorganic material construction.
- Closed magnetic circuit avoids crosstalk.
- Excellent solderability and heat resistance
- High reliability
- Low DC resistance electrode structure



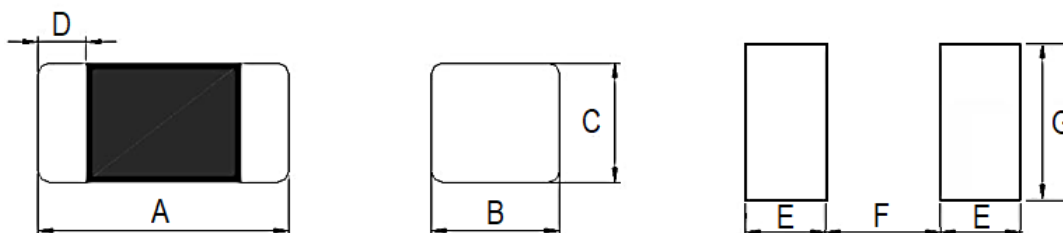
PART NUMBERING SYSTEM



SIM 86 600 Y 6A0 32
(1) (2) (3) (4) (5) (6)

No	item	Code	Description	
(1)	Product Code	SIM	Signal Chip Inductor, Multi-Layer Chip Ferrite Bead Type	
(2)	Dimension	86	86: 1806, 4.5x1.6mm	See Dimension Table
(3)	Impedence	600	600: 60Ω	First two: Significant, Third: Multiplier
(4)	Tolerance	Y	Y: ±25%	-25% ~ +25%
(5)	Rated Current	6A0	6A0: 6.0A	Max Current, 'A' denotes decimal point
(6)	Series Code	32	Chip Ferrite Bead, High Current Type	Internal Control Code

DIMENSIONS



Size Code	A (mm)	B (mm)	C (mm)	D (mm)	E (mm)	F (mm)	G (mm)
SIM02 (0402)	1.00±0.10	0.50±0.10	0.50±0.10	0.25±0.10	0.50	0.40	0.60
SIM03 (0603)	1.60±0.15	0.80±0.15	0.80±0.15	0.30±0.20	0.80	0.85	0.95
SIM05 (0805)	2.00±0.20	1.25±0.20	0.85±0.20	0.50±0.30	1.05	1.00	1.45
SIM06 (1206)	3.20±0.20	1.60±0.20	1.10±0.20	0.50±0.30	1.05	2.20	1.80
SIM86 (1806)	4.50±0.20	1.60±0.20	1.60±0.20	0.50±0.30	1.05	3.30	1.80
SIM82 (1812)	4.50±0.20	3.20±0.20	1.50±0.20	0.50±0.30	1.05	3.30	3.40

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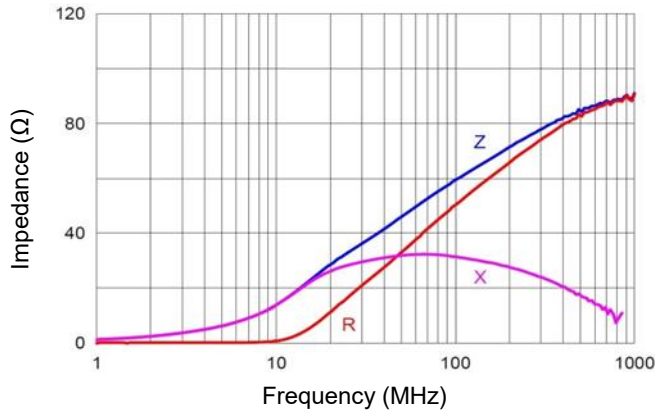
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ELECTRICAL CHARACTERISTICS

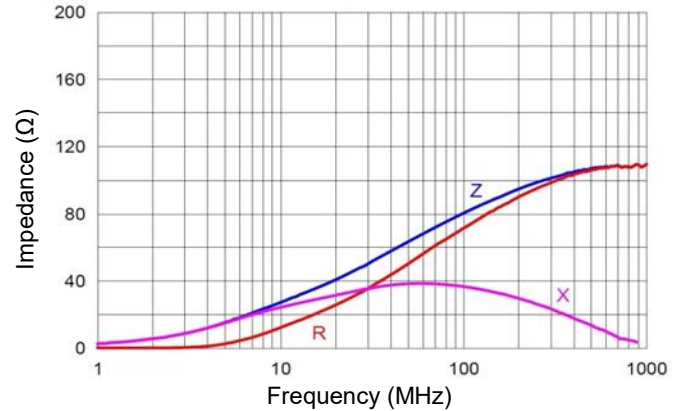
Size	Part Number	Impedance (Ω)	Tolerance (%)	Test Frequency (MHz)	DCR (Ω) Max	Rated Current (mA)
1806	SIM86600Y6A032	60	± 25	60mV/100	0.01	6000
	SIM86800Y3A032	80	± 25	60mV/100	0.04	3000

CHARACTERISTIC CURVES

SIM86600Y6A032

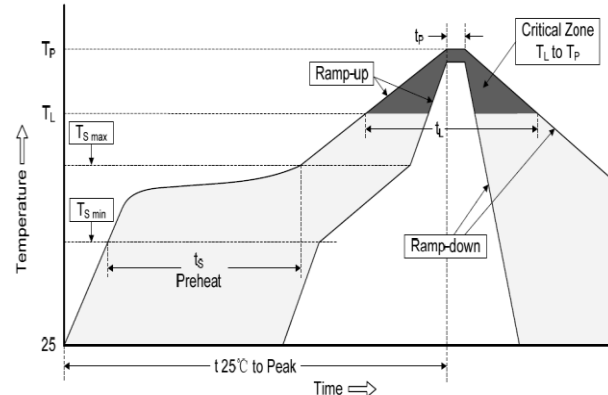


SIM86800Y3A032

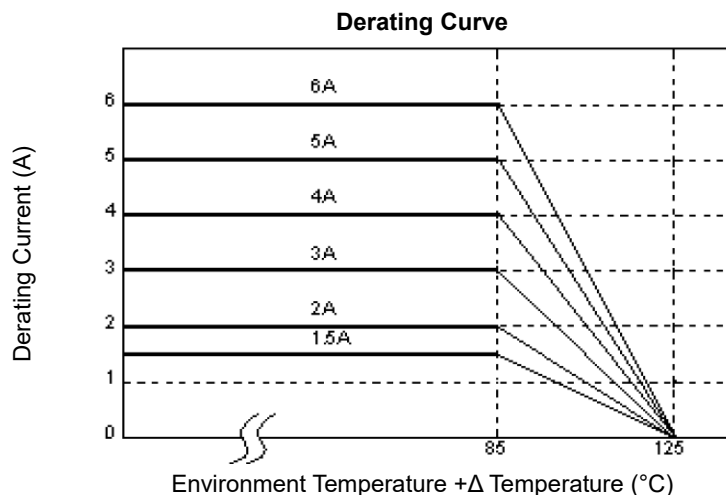


RECOMMENDED SOLDERING PROFILES

Reflow Condition		
Pre Heat	Temp. Min $T_{s(min)}$	150°C
	Temp. Max $T_{s(max)}$	200°C
	Time (min. to max.) (t_s)	60 ~ 180 seconds
Reflow	Temp. (T_L)	217°C
	Time (min. to max.) (t_L)	60 ~ 150 seconds
Peak Temperature (T_P)		260°C
Time within 5°C of actual peak Temperature (t_P)		10 seconds max.
Reflow times:		3 times Max.



DERATING CURVE



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RELIABILITY TEST CONDITON AND REQUIREMENT

Item	Test Conditions	Requirement															
Temperature Rise Test	Applied the allowed DC current. Temperature measured by digital surface thermometer.	Rated Current < 1A ΔT 20°CMax. Rated Current ≥ 1A ΔT 40°CMax.															
Solderability	Method B, 4hrs @ 155°C dry heat @ 235±5°C Test time: 5 +0/-0.5 sec. Method D category 3. (steam aging 8hrs±15min) @ 260±5°C Test time: 30 +0/-0.5sec.	More than 95% of the terminal electrode should be covered with solder.															
Resistance to Soldering Heat	Solder temperature: 260±5°C for 10±1 seconds; Temperature ramp/immersion and emersion rate: 25mm/s ±6 mm/s. Depth: Completely cover the termination.	Appearance: no damage. Impedance: within±15%of initial value. Inductance: within±10%of initial value.															
Vibration	Preconditioning: Run through IR reflow for 3 times. Oscillation Frequency: 10~2K~10 Hz for 20 minutes Equipment: Vibration checker, Total Amplitude:10g Testing Time: 12 hours (20 minutes, 12 cycles each of 3 orientations)	Appearance: no damage. Impedance: within±15%of initial value. Inductance: within±10%of initial value.															
Shock	Test condition: <table><tr><th>Type</th><th>Peak Value (g's)</th><th>Normal duration (ms)</th><th>Wave From</th><th>Velocity change (ft/sec)</th></tr><tr><td>SMD</td><td>50</td><td>11</td><td>Half-sine</td><td>11.3</td></tr><tr><td>Lead</td><td>50</td><td>11</td><td>Half-sine</td><td>11.3</td></tr></table>	Type	Peak Value (g's)	Normal duration (ms)	Wave From	Velocity change (ft/sec)	SMD	50	11	Half-sine	11.3	Lead	50	11	Half-sine	11.3	Appearance: no damage. Impedance: within±10%of initial value. Inductance: within±10%of initial value.
Type	Peak Value (g's)	Normal duration (ms)	Wave From	Velocity change (ft/sec)													
SMD	50	11	Half-sine	11.3													
Lead	50	11	Half-sine	11.3													
Terminal strength	Preconditioning: Run through IR reflow for 3 times. With component mounted on a PCB apply a force >0805:1kg, <=0805:0.5kg to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also, the force shall be applied gradually as not to shock the component being tested.	Appearance: no damage. Impedance: within±15%of initial value. Inductance: within±10%of initial value.															
Thermal Shock	Preconditioning: Run through IR reflow for 3 times. Number of cycles: 500. Condition for 1 cycle: <table><tr><th>No.</th><th>Temp. (°C)</th><th>Time (min.)</th></tr><tr><td>1</td><td>-55±2°C</td><td>30±5</td></tr><tr><td>2</td><td>125±2°C</td><td>≤30 seconds</td></tr><tr><td>3</td><td>+125±2°C</td><td>30±5</td></tr></table> Measured at room temperature after placing for 24±2 hrs.	No.	Temp. (°C)	Time (min.)	1	-55±2°C	30±5	2	125±2°C	≤30 seconds	3	+125±2°C	30±5	Appearance: no damage. Impedance: within±15%of initial value. Inductance: within±10%of initial value.			
No.	Temp. (°C)	Time (min.)															
1	-55±2°C	30±5															
2	125±2°C	≤30 seconds															
3	+125±2°C	30±5															
Bending	Shall be mounted on a FR4 substrate of the following dimensions: <table><tr><th>Dimensions</th><th>Bending depth</th></tr><tr><td>>=0805:40x100x1.2mm</td><td>1.2mm</td></tr><tr><td><0805:40x100x0.8mm</td><td>0.8mm</td></tr></table> Duration of 10 sec for a min.	Dimensions	Bending depth	>=0805:40x100x1.2mm	1.2mm	<0805:40x100x0.8mm	0.8mm	Appearance: no damage. Impedance: within±10%of initial value. Inductance: within±10%of initial value.									
Dimensions	Bending depth																
>=0805:40x100x1.2mm	1.2mm																
<0805:40x100x0.8mm	0.8mm																
Load Humidity	Preconditioning: Run through IR reflow for 3 times. Humidity: 85±2%R.H. Temperature: 85±2°C. Duration: 1000hrs Min. with 100% rated current. Measured at room temperature after 24±2 hrs.	Appearance: no damage. Impedance: within±15%of initial value. Inductance: within±10%of initial value.															
Life Test	Preconditioning: Run through IR reflow for 3 times. Temperature: 125±2°C Applied current: rated current. Duration: 1000±12 Hrs. Measured at room temperature after 24±2 Hrs.	Appearance: no damage. Impedance: within±15%of initial value. Inductance: within±10%of initial value.															

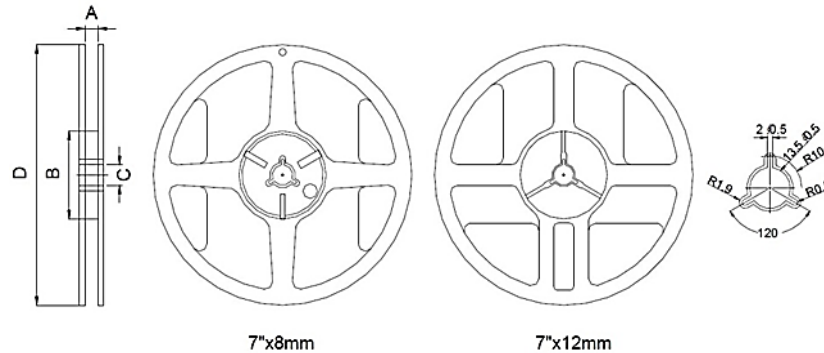
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PACKAGING SPECIFICATIONS

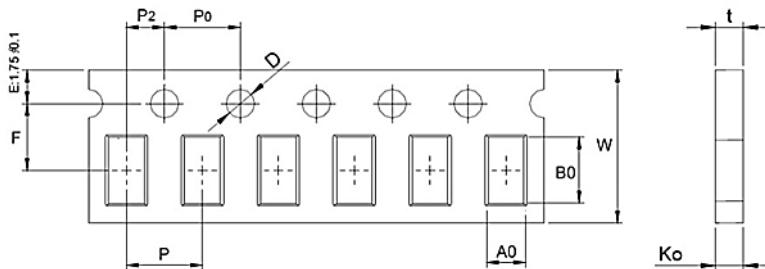
Reel Specification & Packaging Quantity



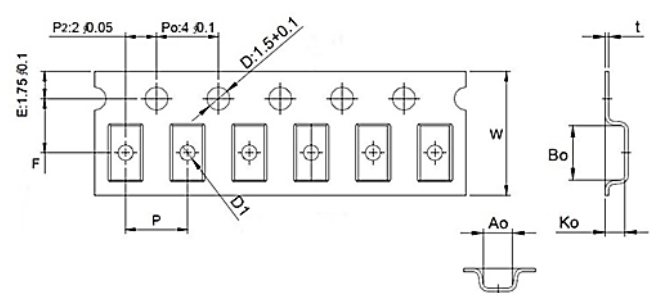
Size	Reel Dimension (mm)						
	Quantity	Tape Width	Reel Diameter	A	B	C	D
0402	Paper 10K	8mm	7"	9.5±0.5	60.0±2.0	13.5±0.5	178.0±2.0
0603	Paper 4K	8mm	7"	9.5±0.5	60.0±2.0	13.5±0.5	178.0±2.0
0805	Paper 4K	8mm	7"	9.5±0.5	60.0±2.0	13.5±0.5	178.0±2.0
1206	Plastic 3K	8mm	7"	9.5±0.5	60.0±2.0	13.5±0.5	178.0±2.0
1806	Plastic 2K	12mm	7"	13.5±0.5	60.0±2.0	13.5±0.5	178.0±2.0
1812	Plastic 1K	12mm	7"	13.5±0.5	60.0±2.0	13.5±0.5	178.0±2.0

PACKAGING SPECIFICATIONS

Paper Tape Specification



Plastic Tape Specification



Size	Paper Tape Dimension (mm)									
	A0	B0	W	F	P0	P	P2	D	t	Ko
0402	0.62±0.03	1.12±0.03	8±0.3	3.5±0.05	4±0.1	2±0.05	-	1.5±0.1	0.6±0.03	0.6±0.03
0603	0.96±0.05/-0.03	1.80±0.05	8±0.1	3.5±0.1	4±0.1	4±0.1	2±0.1	1.56±0.1/-0.05	0.95±0.05	0.95±0.05
0603*	0.97±0.03	1.78±0.03	8±0.1	3.5±0.1	4±0.1	4±0.1	2±0.1	1.56±0.1/-0.05	0.75±0.03	0.75±0.03
0805	1.3±0.05	2.1±0.05	8±0.1	3.5±0.1	4±0.1	4±0.1	2±0.1	1.56±0.1/-0.05	0.95±0.05	0.95±0.05
Size	Plastic Tape Dimension (mm)									
	A0	B0	W	F	P	P0	P2	D1	t	Ko
1206	1.75±0.1	3.35±0.1	8±0.1	3.5±0.05	4±0.1	4±0.1	2±0.05	1±0.1	0.23±0.05	1.25±0.1
1806	1.75±0.1	4.7±0.1	12±0.1	5.5±0.05	4±0.1	4±0.1	2±0.05	1.5±0.1	0.24±0.05	1.75±0.1
1812	3.45±0.1	4.7±0.1	12±0.1	5.5±0.05	8±0.1	4±0.1	2±0.05	1.5±0.1	0.24±0.05	1.60±0.1

Notes: *0603 impedance value 26Ω, thickness is 0.60mm

*Specifications subject to change without notice.